# **Operational Amplifier, Railto-Rail Output, 3 MHz BW**

The NCx2007x series operational amplifiers provide rail-to-rail output operation, 3 MHz bandwidth, and are available in single, dual, and quad configurations. Rail-to-rail operation enables the user to make optimal use of the entire supply voltage range while taking advantage of 3 MHz bandwidth. The NCx2007x can operate on supply voltages as low as 2.7 V over the temperature range of  $-40^{\circ}$ C to 125°C. At a 2.7 V supply, the high bandwidth provides a slew rate of 2.8 V/µs while only consuming 405 µA of quiescent current per channel. The wide supply range allows the NCx2007x to run on supply voltages as high as 36 V, making it ideal for a broad range of applications. Since this is a CMOS device, high input impedance and low bias currents make it ideal for interfacing to a wide variety of signal sensors. The NCx2007x devices are available in a variety of compact packages. Automotive qualified options are available under the NCV prefix.

### Features

- Rail-To-Rail Output
- Wide Supply Range: 2.7 V to 36 V
- Wide Bandwidth: 3 MHz typical at  $V_S = 2.7 V$
- High Slew Rate: 2.8 V/ $\mu$ s typical at V<sub>S</sub> = 2.7 V
- Low Supply Current: 405  $\mu$ A per channel at V<sub>S</sub> = 2.7 V
- Low Input Bias Current: 5 pA typical
- Wide Temperature Range: -40°C to 125°C
- Available in a variety of packages
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q100 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

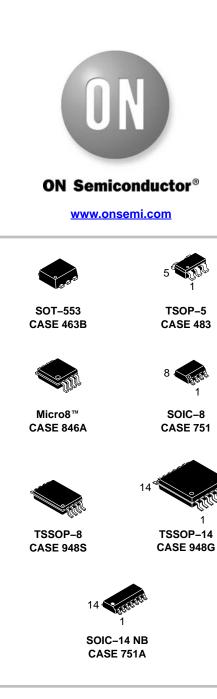
### Applications

- Current Sensing
- Signal Conditioning
- Automotive

#### **End Products**

- Notebook Computers
- Portable Instruments
- Power Supplies

This document contains information on some products that are still under development. ON Semiconductor reserves the right to change or discontinue these products without notice.



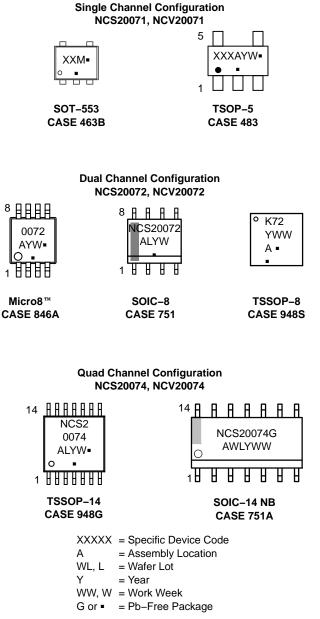
#### **DEVICE MARKING INFORMATION**

See general marking information in the device marking section on page 2 of this data sheet.

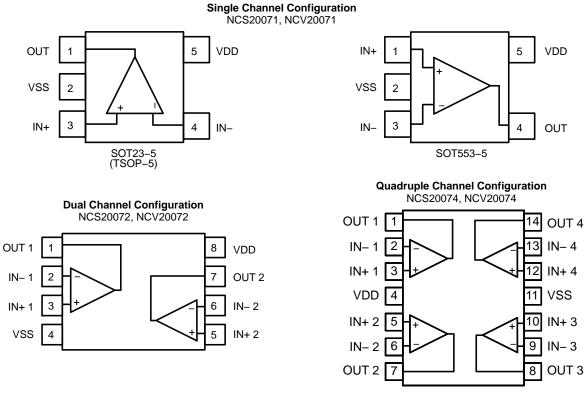
### **ORDERING INFORMATION**

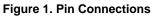
See detailed ordering and shipping information on page 4 of this data sheet.

### MARKING DIAGRAMS



(Note: Microdot may be in either location)





#### **ORDERING INFORMATION**

Device	Configuration	Automotive	Marking	Package	Shipping <sup>†</sup>
NCS20071SN2T1G (In Development)**			TBD	TSOP-5 (Pb-Free)	3000 / Tape and Reel
NCS20071XV53T2G (In Development)**	0 set	No	TBD	SOT553–5 (Pb–Free)	4000 / Tape and Reel
NCV20071SN2T1G* (In Development)**	- Single	No. 5	TBD	TSOP–5 (Pb–Free)	3000 / Tape and Reel
NCV20071XV53T2G* (In Development)**		Yes	TBD	SOT553–5 (Pb–Free)	4000 / Tape and Reel
NCS20072DMR2G			0072	Micro8 (MSOP8) (Pb–Free)	4000 / Tape and Reel
NCS20072DR2G	7	No	NCS20072	SOIC-8 (Pb-Free)	2500 / Tape and Reel
NCS20072DTBR2G			K72	TSSOP-8 (Pb-Free)	2500 / Tape and Reel
NCV20072DMR2G*	— Dual		0072	Micro8 (MSOP8) (Pb–Free)	4000 / Tape and Reel
NCV20072DR2G*		Yes	NCS20072	SOIC-8 (Pb-Free)	2500 / Tape and Reel
NCV20072DTBR2G*	7		K72	TSSOP–8 (Pb–Free)	2500 / Tape and Reel
NCS20074DR2G			NCS20074	SOIC-14 (Pb-Free)	2500 / Tape and Reel
NCS20074DTBR2G		No	NCS2 0074	TSSOP-14 (Pb-Free)	2500 / Tape and Reel
NCV20074DR2G*	Quad	, v	NCS20074	SOIC-14 (Pb-Free)	2500 / Tape and Reel
NCV20074DTBR2G*		Yes	NCS2 0074	TSSOP-14 (Pb-Free)	2500 / Tape and Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D. \*NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC–Q100 Qualified and PPAP

Capable.

\*\*Contact local sales office for availability.

### ABSOLUTE MAXIMUM RATINGS (Note 1)

	Rating	Symbol	Limit	Unit	
Supply Voltage (V <sub>DD</sub> – V <sub>SS</sub>	) (Note 4)	V <sub>S</sub>	40	V	
Input Voltage		V <sub>CM</sub>	$V_{SS}$ – 0.2 to $V_{DD}$ + 0.2	V	
Differential Input Voltage (N	lote 2)	V <sub>ID</sub>	±V <sub>s</sub>	V	
Maximum Input Current	I <sub>IN</sub> ±10				
Maximum Output Current (	Note 3)	Ι <sub>Ο</sub>	±100	mA	
Continuous Total Power Dis	ssipation (Note 4)	PD	200	mW	
Maximum Junction Temper	ature	TJ	T <sub>J</sub> 150		
Storage Temperature Rang	e	T <sub>STG</sub>	-65 to 150	°C	
Mounting Temperature (Infr	ared or Convection – 20 sec)	T <sub>mount</sub>	260	°C	
ESD Capability (Note 5)	Human Body Model Machine Model – NCx20071 Machine Model – NCx20072, NCx20074 Charged Device Model – NCx20071/NCx20072 Charged Device Model – NCx20074	HBM MM CDM CDM	2000 200 150 2000 (C6) 1000 (C6)	V	
Latch–Up Current (Note 6)		Ι <sub>LU</sub>	100	mA	
Moisture Sensitivity Level (	Note 7)	MSL	Level 1		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

- 2. Maximum input current must be limited to ±10 mA. Series connected resistors of at least 500 Ω on both inputs may be used to limit the maximum input current to ±10 mA.
- 3. Total power dissipation must be limited to prevent the junction temperature from exceeding the 150°C limit.
- 4. Continuous short circuit operation to ground at elevated ambient temperature can result in exceeding the maximum allowed junction temperature of 150°C. Output currents in excess of the maximum output current rating over the long term may adversely affect reliability. Shorting output to either VDD or VSS will adversely affect reliability.
- 5. This device series incorporates ESD protection and is tested by the following methods: ESD Human Body Model tested per ANSI/ANSI/ESDA/JEDEC JS-001-2010 (AEC-Q100-002) ESD Machine Model tested per JESD22-A115 (AEC-Q100-003) ESD Charged Device Model tested per ANSI/ESD S5.3.1-2009 (AEC-Q100-011)
- 6. Latch-up Current tested per JEDEC standard: JESD78 (AEC-Q100-004)
- 7. Moisture Sensitivity Level tested per IPC/JEDEC standard: J-STD-020A

### THERMAL INFORMATION

Parameter	Symbol	Package	Single Layer Board (Note 8)	Multi–Layer Board (Note 9)	Unit
		SOT23-5 / TSOP5			
		SOT553-5		178	
	θ <sub>JA</sub>	Micro8 / MSOP8	236	167	
Junction-to-Ambient		SOIC-8	190	131	°C/W
		TSSOP-8	253	194	
		SOIC-14	142	101	
		TSSOP-14	179	128	

8. Values based on a 1S standard PCB according to JEDEC51-3 with 1.0 oz copper and a 300 mm<sup>2</sup> copper area

9. Values based on a 1S2P standard PCB according to JEDEC51-7 with 1.0 oz copper and a 100 mm<sup>2</sup> copper area

#### **OPERATING RANGES**

Parameter	Symbol	Min	Max	Unit
Operating Supply Voltage (Single Supply)	VS	2.7	36	V
Operating Supply Voltage (Split Supply)	VS	±1.35	±18	V
Differential Input Voltage (Note 10)	V <sub>ID</sub>		Vs	V
Input Common Mode Voltage Range	V <sub>CM</sub>	V <sub>SS</sub>	V <sub>DD</sub> – 1.35	V
Ambient Temperature	T <sub>A</sub>	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

10. Maximum input current must be limited to ±10 mA. See Absolute Maximum Ratings for more information.

### ELECTRICAL CHARACTERISTICS AT $V_S = 2.7 V$

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply unless otherwise noted}$ . All limits are guaranteed by testing or statistical analysis. **Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 11, 12)

Parameter	Symbol	Cond	itions	Min	Тур	Max	Unit
INPUT CHARACTERISTICS						-	-
Innut Offeet Veltege	M				1.3	±3	mV
Input Offset Voltage	V <sub>OS</sub>					±4	mV
Offset Voltage Drift	$\Delta V_{OS} / \Delta T$	$T_A = 25^{\circ}C$	C to 125°C		2		μV/°C
Innut Rice Current (Note 12)					5	200	- 0
Input Bias Current (Note 12)	I <sub>IB</sub>					1500	рА
		NCx20072			2	75	
Input Offact Current (Note 12)		NCX2	20072			500	pА
Input Offset Current (Note 12)	los	NOv	0074		2	75	
		NCx20074				200	
Channel Constation	NCx20072	NCx20072		100		dB	
Channel Separation	XTLK	DC	NCx20074		115		uБ
Differential Input Resistance	R <sub>ID</sub>				50		GΩ
Common Mode Input Resistance	R <sub>IN</sub>				5		GΩ
Differential Input Capacitance	C <sub>ID</sub>				1.5		pF
Common Mode Input Capacitance	C <sub>CM</sub>				3.5		pF
		$V_{CM} = V_{SS} + 0.2 \text{ V to}$	NO:00070	90	110		dB
O		$V_{CM} = V_{SS} + 0.2 V$ to $V_{DD} - 1.35 V$	NCx20072	69			
Common Mode Rejection Ratio	CMRR	V <sub>CM</sub> = V <sub>SS</sub> to V <sub>DD</sub> – 1.35 V (Note 13)	NCx20074	90	110		dB
				69			

#### **OUTPUT CHARACTERISTICS**

Open Loop Voltage Gain	A		96	118		dB
Open Loop voltage Gain	A <sub>VOL</sub>		86			uВ
Output Current Capability (Note 14)		Op amp sinking current		70		~^^
	ι <sub>Ο</sub>	Op amp sourcing current		50		mA
	V <sub>OH</sub>	Voltage output output from positive roll		0.006	0.15	v
Output Voltage High		Voltage output swing from positive rail			0.22	
		Voltage output output from pagetive roll		0.005	0.15	v
Output Voltage Low	V <sub>OL</sub>	Voltage output swing from negative rail			0.22	

#### AC CHARACTERISTICS

Unity Gain Bandwidth	UGBW	C <sub>L</sub> = 25 pF			3		MHz
Slew Rate at Unity Gain	SR	$C_L$ = 20 pF, $R_L$ = 2 k $\Omega$			2.8		V/µs
Phase Margin	φm	C <sub>L</sub> = 25 pF			50		0
Gain Margin	A <sub>m</sub>	C <sub>L</sub> =	C <sub>L</sub> = 25 pF		14		dB
		V <sub>O</sub> = 1 Vpp, Gain = 1, C <sub>L</sub> = 20 pF	Settling time to 0.1%		0.6		μs
Settling Time	t <sub>S</sub>		Settling time to 0.01%		1.2		

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

11. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

12. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

13. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to  $V_{CM} = V_{SS} + 0.2$  V to  $V_{DD} - 1.35$  V.

#### ELECTRICAL CHARACTERISTICS AT V<sub>S</sub> = 2.7 V

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply}$  unless otherwise noted. All limits are guaranteed by testing or statistical analysis. **Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 11, 12)

Parameter	Symbol	Conditions		Тур	Max	Unit
NOISE CHARACTERISTICS						
Total Harmonic Distortion plus Noise	THD+N	$V_{IN} = 0.5 Vpp, f = 1 kHz, Av = 1$		0.05		%
Janut Deferred Veltere Naise		f = 1 kHz		30		nV/√ <del>Hz</del>
Input Referred Voltage Noise	e <sub>n</sub>	f = 10 kHz		20		nv/vHz
Input Referred Current Noise	i <sub>n</sub>	f = 1 kHz		0.25		fA/√Hz

Power Supply Rejection Ratio	PSRR	R No Load		135		dB	
Fower Supply Rejection Ratio	FORK	NU LUAU	100			uв	
Power Supply Quiescent Current	v Quiessent Current	Per channel, no load		405	525		
Power Supply Quiescent Current	IDD	Fer channel, no load			625	μΑ	

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

11. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

Symbol

12. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

13. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to VCM  $= V_{SS} + 0.2 V$  to  $V_{DD} - 1.35 V$ .

14. Power dissipation must be limited to prevent junction temperature from exceeding 150°C. See Absolute Maximum Ratings for more information.

Conditions

Min Typ Max Unit

Parameter

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**ELECTRICAL CHARACTERISTICS AT V<sub>S</sub> = 5 V**   $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply unless otherwise noted}$ . All limits are guaranteed by testing or statistical analysis. **Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 15, 16)

Falailletei	Symbol		multions	IVIIII	тур	IVIAX	Unit
INPUT CHARACTERISTICS							
					1.3	±3	mV
Input Offset Voltage	V <sub>OS</sub>					±4	mV
Offset Voltage Drift	$\Delta V_{OS} / \Delta T$	T <sub>A</sub> = 2	5°C to 125 °C		2		μV/°C
Innut Diag Current (Nate 16)					5	200	<b>n</b> A
Input Bias Current (Note 16)	I <sub>IB</sub>					1500	рА
			Cx20072		2	75	рА
nout Offect Current (Note 16)		NC220072				500	
Input Offset Current (Note 16)	l <sub>os</sub>	NCx20074			2	75	
						200	
Ohannal Constitut	VTLK	DC	NCx20072		100		٩D
Channel Separation	XTLK	DC	NCx20074		115		dB
Differential Input Resistance	R <sub>ID</sub>		•		50		GΩ
Common Mode Input Resistance	R <sub>IN</sub>				5		GΩ
Differential Input Capacitance	C <sub>ID</sub>				1.5		pF
Common Mode Input Capacitance	C <sub>CM</sub>				3.5		pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

15. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

16. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

17. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to VCM  $= V_{SS} + 0.2 V$  to  $V_{DD} - 1.35 V$ .

### ELECTRICAL CHARACTERISTICS AT $V_S = 5 V$

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply unless otherwise noted}$ . All limits are guaranteed by testing or statistical analysis. **Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 15, 16)

Parameter	Symbol	Condi	tions	Min	Тур	Max	Unit
INPUT CHARACTERISTICS							
		$V_{CM} = V_{SS} + 0.2 V$ to	10,00070	102	125		
	01100	V <sub>DD</sub> – 1.35 V	NCx20072	80			dB
Common Mode Rejection Ratio	CMRR	$V_{CM} = V_{SS}$ to $V_{DD} =$	10 00074	102	125		
		V <sub>CM</sub> = V <sub>SS</sub> to V <sub>DD</sub> – 1.35 V (Note 17)	NCx20074	80			dB
OUTPUT CHARACTERISTICS							-
	•			96	120		JD
Open Loop Voltage Gain	A <sub>VOL</sub>			86			dB
		Op amp sinl	king current		50		
Output Current Capability (Note 18)	lo	Op amp sourcing current			60		mA
Outrut Valence Llink	M				0.013	0.20	V
Output Voltage High	V <sub>OH</sub>	Voltage output swin	ig from positive rail			0.25	V
Output Mallana Laur		Malta na antro tanta ant	- factor and the second		0.01	0.10	
Output Voltage Low	V <sub>OL</sub>	Voltage output swing from negative rail				0.15	V
AC CHARACTERISTICS							
Unity Gain Bandwidth	UGBW	C <sub>L</sub> = 25 pF			3.2		MHz
Slew Rate at Unity Gain	SR	$C_{L} = 20 \text{ pF},$	$R_L = 2 k\Omega$		2.7		V/μs
Phase Margin	φm	C <sub>L</sub> = 2	25 pF		50		0
Gain Margin	A <sub>m</sub>	C <sub>L</sub> = 2	25 pF		14		dB
Cattling Time		V <sub>O</sub> = 3 Vpp,	Settling time to 0.1%		1.2		
Settling Time	t <sub>S</sub>		Settling time to 0.01%		5.6		μS
NOISE CHARACTERISTICS							
Total Harmonic Distortion plus Noise	THD+N	V <sub>IN</sub> = 2.5 Vpp, f	= 1 kHz, Av = 1		0.009		%
Innut Deferred Veltere Naise	_	f = 1	kHz		30		*)///II=
Input Referred Voltage Noise	e <sub>n</sub>	f = 10	kHz		20		nV/√Hz
Input Referred Current Noise	i <sub>n</sub>	f = 1	kHz		0.25		fA/√Hz
SUPPLY CHARACTERISTICS							
Dowor Cupply Deigsting Datis		NI- 1	aad	114	135		dD
Power Supply Rejection Ratio	PSRR	No L	.0a0	100			dB
			al and land		410	530	
Power Supply Quiescent Current	I <sub>DD</sub>	Per channe	ei, no load			630	μΑ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

15. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

16. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

17. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to  $V_{CM} = V_{SS} + 0.2 \text{ V}$  to  $V_{DD} - 1.35 \text{ V}$ .

### ELECTRICAL CHARACTERISTICS AT $V_S = 10 V$

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply}$  unless otherwise noted. All limits are guaranteed by testing or statistical analysis. Boldface limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 19, 20)

Parameter	Symbol	Cond	itions	Min	Тур	Max	Unit	
INPUT CHARACTERISTICS	•	•						
Innut Offeet Veltege	M				1.3	±3	mV	
Input Offset Voltage	V <sub>OS</sub>					±4	mV	
Offset Voltage Drift	$\Delta V_{OS} / \Delta T$	$T_A = 25^{\circ}C$	C to 125°C		2		μV/°C	
Input Bias Current (Note 20)	l				5	200	рА	
Input bias Current (Note 20)	I <sub>IB</sub>					1500	РА	
		NCx20072			2	75		
Input Offset Current (Note 20)	1	INCX2	10720072			500	рА	
input Onset Guiterit (Note 20)	l <sub>OS</sub>	NCx20074			2	75		
						200		
Channel Constation	XTLK	DC	NCx20072		100	dP	dD	
Channel Separation	AILK	DC	NCx20074		115		dB	
Differential Input Resistance	R <sub>ID</sub>				50		GΩ	
Common Mode Input Resistance	R <sub>IN</sub>				5		GΩ	
Differential Input Capacitance	C <sub>ID</sub>				1.5		pF	
Common Mode Input Capacitance	C <sub>CM</sub>				3.5		pF	
		$V_{CM} = V_{SS} + 0.2 \text{ V to}$	NO:00070	110	130		dB	
Common Made Deiestien Detie	CMRR	V <sub>DD</sub> – 1.35 V	NCx20072	87				
Common Mode Rejection Ratio		V <sub>CM</sub> = V <sub>SS</sub> to V <sub>DD</sub> - 1.35 V (Note 21)	NCx20074	110	130		dB	
				87				

#### **OUTPUT CHARACTERISTICS**

Open Loop Voltage Gain	A		98	120		dB
Open Loop voltage Gain	A <sub>VOL</sub>		88			uВ
Output Output Conshility (Note 22)		Op amp sinking current		50		~ ^
Output Current Capability (Note 22)	IO	Op amp sourcing current		65		mA
	M			0.023	0.08	V
Output Voltage High	V <sub>OH</sub>	Voltage output swing from positive rail			0.10	v
	M	Voltage output output from pagetive roll		0.022	0.3	V
Output Voltage Low	V <sub>OL</sub>	Voltage output swing from negative rail			0.35	v

#### AC CHARACTERISTICS

Unity Gain Bandwidth	UGBW	C <sub>L</sub> = 25 pF		3.2	MHz
Slew Rate at Unity Gain	SR	$C_L = 20 \text{ pF}, R_L = 2 \text{ k}\Omega$		2.2	V/μs
Phase Margin	φm	C <sub>L</sub> =	25 pF	50	0
Gain Margin	A <sub>m</sub>	C <sub>L</sub> =	25 pF	14	dB
Cottling Time		V <sub>O</sub> = 8.5 Vpp,	Settling time to 0.1%	3.4	
Settling Time	t <sub>S</sub>	$V_{O} = 8.5 Vpp,$ Gain = 1, C <sub>L</sub> = 20 pF	Settling time to 0.01%	6.8	μs

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

19. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

20. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

21. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to  $V_{CM} = V_{SS} + 0.2 \text{ V}$  to  $V_{DD} - 1.35 \text{ V}$ .

#### ELECTRICAL CHARACTERISTICS AT V<sub>S</sub> = 10 V

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply}$  unless otherwise noted. All limits are guaranteed by testing or statistical analysis. Boldface limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $125^{\circ}C$ . (Notes 19, 20)

Symbol	Conditions		Тур	Max	Unit
THD+N	V <sub>IN</sub> = 7.5 Vpp, f = 1 kHz, Av = 1		0.004		%
	f = 1 kHz		30		
e <sub>n</sub>	f = 10 kHz		20		nV/√Hz
i <sub>n</sub>	f = 1 kHz		0.25		fA/√Hz
	THD+N e <sub>n</sub>	THD+N $V_{IN} = 7.5$ Vpp, f = 1 kHz, Av = 1 $e_n = \frac{f = 1 \text{ kHz}}{f = 10 \text{ kHz}}$	THD+N $V_{IN} = 7.5$ Vpp, f = 1 kHz, Av = 1 $e_n = \frac{f = 1 \text{ kHz}}{f = 10 \text{ kHz}}$	THD+N $V_{IN} = 7.5$ Vpp, f = 1 kHz, Av = 1    0.004 $e_n$ f = 1 kHz    30      f = 10 kHz    20      i    f = 1 kHz    0.25	THD+N $V_{IN} = 7.5$ Vpp, f = 1 kHz, Av = 1    0.004 $e_n$ f = 1 kHz    30      f = 10 kHz    20      i    f = 1 kHz    0.25

Power Supply Rejection Ratio	PSRR	No Load	114	135		dB
Power Supply Rejection Ratio	FORK	NO LUAU	100			uВ
Power Supply Quiescent Current	I	Per channel, no load		416	540	۵
Power Supply Quiescent Current	IDD	rei channel, no load			640	μΑ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

19. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

20. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

21. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to VCM  $= V_{SS} + 0.2 V$  to  $V_{DD} - 1.35 V$ .

22. Power dissipation must be limited to prevent junction temperature from exceeding 150°C. See Absolute Maximum Ratings for more information.

#### ELECTRICAL CHARACTERISTICS AT V<sub>S</sub> = 36 V

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply unless otherwise noted}$ . All limits are guaranteed by testing or statistical analysis. Boldface limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to 125°C. (Notes 23, 24)

Parameter	Symbol	Conditions		Min	Тур	Max	Unit
INPUT CHARACTERISTICS							
lagest Offeret ) /altage					1.3	±3	mV
Input Offset Voltage	V <sub>OS</sub>					±4	mV
Offset Voltage Drift	$\Delta V_{OS} / \Delta T$	$T_A = 2$	25°C to 125°C		2		μV/°C
					5	200	
Input Bias Current (Note 24)	I <sub>IB</sub>	Ν	ICx20072			2000	pА
		Ν	NCx20074			1500	
		NCx20072			2	75	
lanut Offact Current (Nata 24)		N	ICX20072			1000	<b>~</b> ^
Input Offset Current (Note 24)	los	N	10		2	75	рА
		IN	ICx20074			200	
	VTUK	50	NCx20072		100		10
Channel Separation	XTLK	DC	NCx20074		115		dB
Differential Input Resistance	R <sub>ID</sub>				50		GΩ
Common Mode Input Resistance	R <sub>IN</sub>				5		GΩ
Differential Input Capacitance	C <sub>ID</sub>				1.5		pF
Common Mode Input Capacitance	C <sub>CM</sub>				3.5		pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

23. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

24. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

25. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to VCM = V<sub>SS</sub> + 0.2 V to V<sub>DD</sub> - 1.35 V.

### ELECTRICAL CHARACTERISTICS AT $V_S = 36 V$

 $T_A = 25^{\circ}C$ ;  $R_L \ge 10 \text{ k}\Omega$ ;  $V_{CM} = V_{OUT} = \text{mid-supply unless otherwise noted}$ . All limits are guaranteed by testing or statistical analysis. Boldface limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to 125°C. (Notes 23, 24)

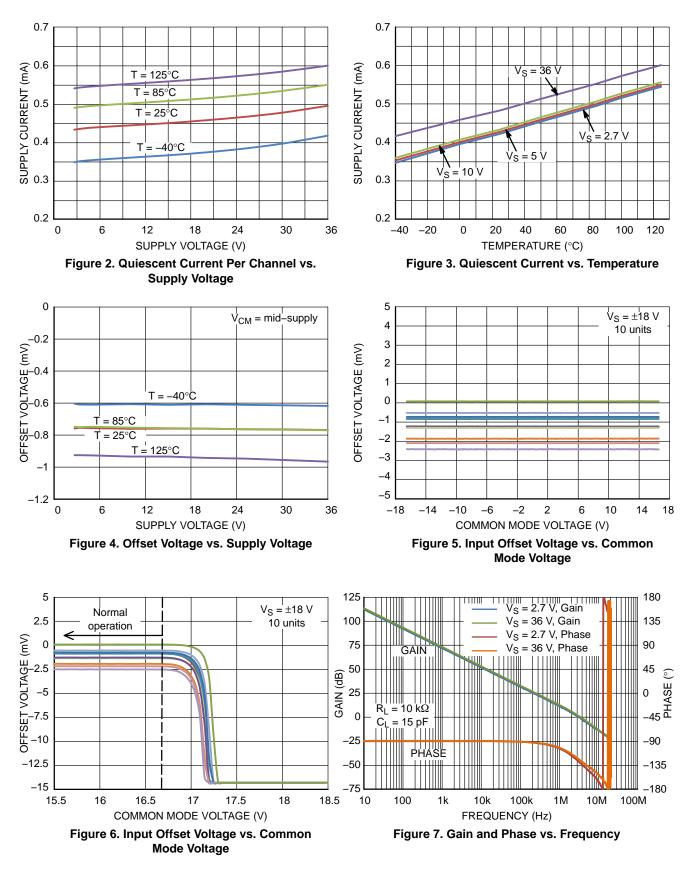
Parameter	Symbol	Cond	itions	Min	Тур	Max	Unit
INPUT CHARACTERISTICS							
		$V_{CM} = V_{SS} + 0.2 V to$		120	145		
	01/25	$V_{CM} = V_{SS} + 0.2 V$ to $V_{DD} - 1.35 V$	NCx20072	95			
Common Mode Rejection Ratio	CMRR	$V_{CM} = V_{SS}$ to $V_{DD}$ –	NO 00074	120	145		dB
		1.35 V (Note 25)	NCx20074	95			
OUTPUT CHARACTERISTICS							
Onen Leen Maltana Cain	٨				120		
Open Loop Voltage Gain	A <sub>VOL</sub>			88			dB
Output Output Oppohility (Nata 20)		Op amp sin	Op amp sinking current		50		
Output Current Capability (Note 26)	Ι <sub>Ο</sub>	Op amp sou	rcing current		65		mA
					0.074	0.10	
Output Voltage High	V <sub>OH</sub>	Voltage output swing from positive rail	NCx20072			0.15	V
			NCx20074			0.12	<u> </u>
Output Voltage Low	M.	Voltago output swir	a from pogativo rail		0.065	0.3	v
Output Voltage Low	V <sub>OL</sub>	voltage output swir	ng from negative rail			0.35	v
AC CHARACTERISTICS							
Unity Gain Bandwidth	UGBW	C <sub>L</sub> =	25 pF		3.2		MHz
Slew Rate at Unity Gain	SR	C <sub>L</sub> = 20 pF	$R_{L} = 2 k\Omega$		2.4		V/µs
Phase Margin	φm	C <sub>L</sub> =	25 pF		50		0
Gain Margin	A <sub>m</sub>	C <sub>L</sub> =	25 pF		14		dB
Cattling Time		V <sub>O</sub> = 10 Vpp,	Settling time to 0.1%		3.2		
Settling Time	t <sub>S</sub>	Gain = 1, $C_L$ = 20 pF	Settling time to 0.01%		6.8		μS
NOISE CHARACTERISTICS							
Total Harmonic Distortion plus Noise	THD+N	V <sub>IN</sub> = 28.5 Vpp,	f = 1 kHz, Av = 1		0.001		%
Input Referred Voltage Noise	0	f = 1	kHz		30		nV/√Hz
Input Releffed Voltage Noise	e <sub>n</sub>	f = 10	) kHz		20		110/3112
Input Referred Current Noise	i <sub>n</sub>	f = 1	kHz		0.25		fA/√Hz
SUPPLY CHARACTERISTICS							
Dower Supply Dejection Datio		No.	aad	114	135		٩D
Power Supply Rejection Ratio	PSRR		_oad	100			dB
			NCv20070		465	570	
		NCx20072			700		
Power Supply Quiescent Current	oply Quiescent Current I <sub>DD</sub> Per channel, no load		NCv20074		465	600	μΑ
		NCx20074			700		

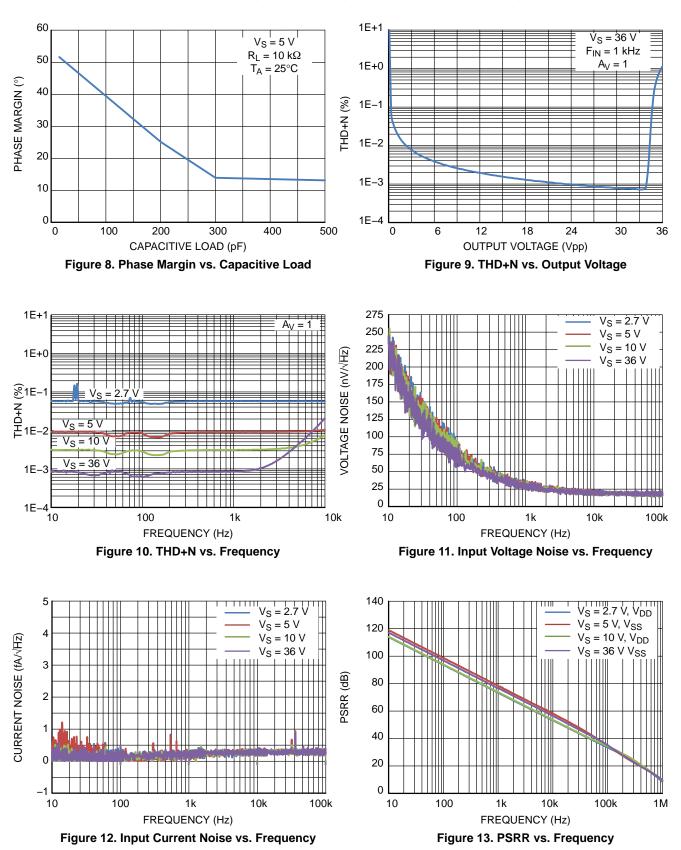
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

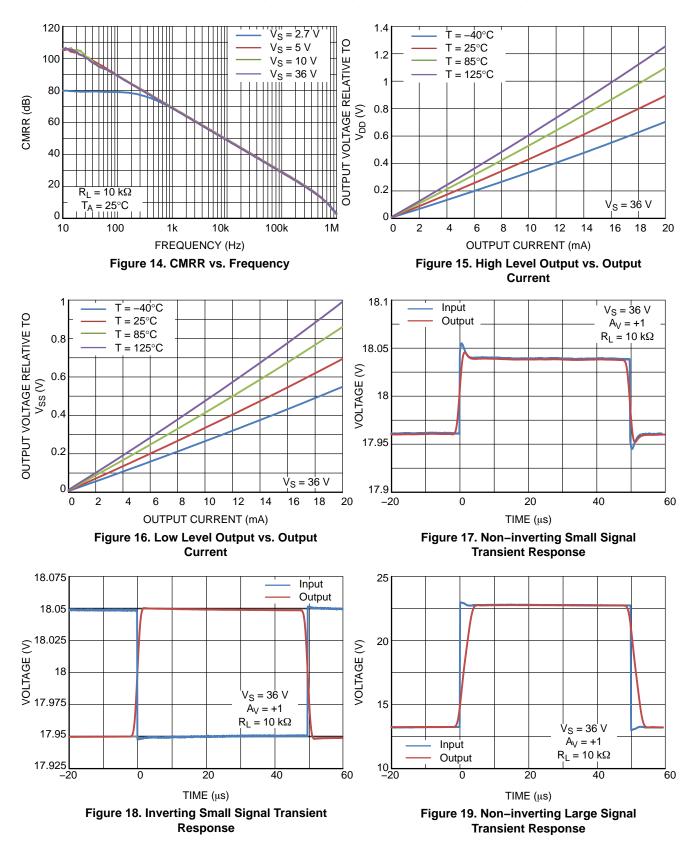
23. Refer to ABSOLUTE MAXIMUM RATINGS and APPLICATION INFORMATION for Safe Operating Area.

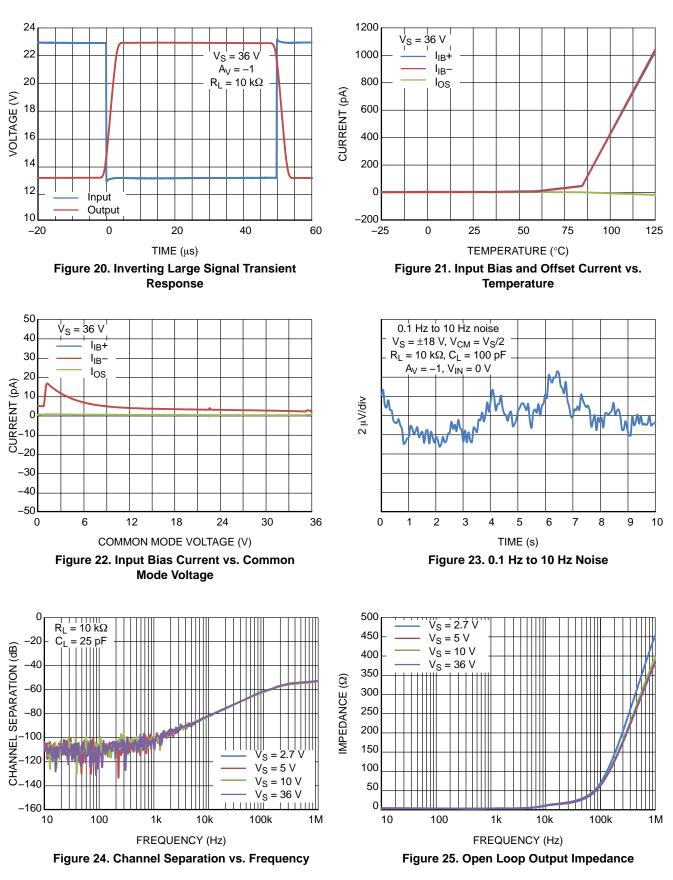
24. Performance guaranteed over the indicated operating temperature range by design and/or characterization.

25. Effective for the NCx20074 until FPCN 20949 is implemented. After the FPCN is implemented, the NCx20074 condition will change to  $V_{CM} = V_{SS} + 0.2 \text{ V to } V_{DD} - 1.35 \text{ V}.$ 









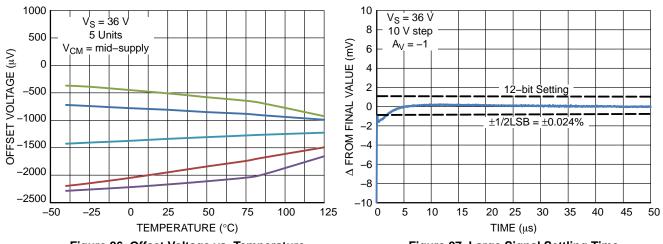
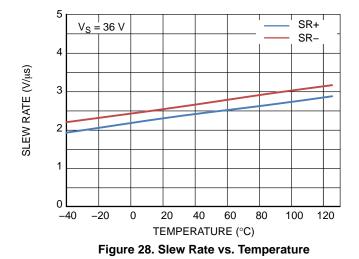


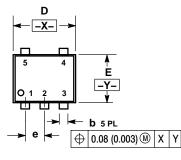
Figure 26. Offset Voltage vs. Temperature

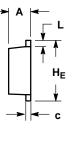
Figure 27. Large Signal Settling Time



### PACKAGE DIMENSIONS

SOT-553, 5 LEAD CASE 463B ISSUE C

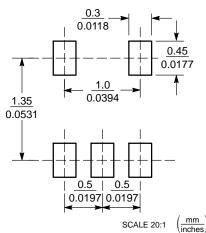




NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETERS 3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL. INCHES

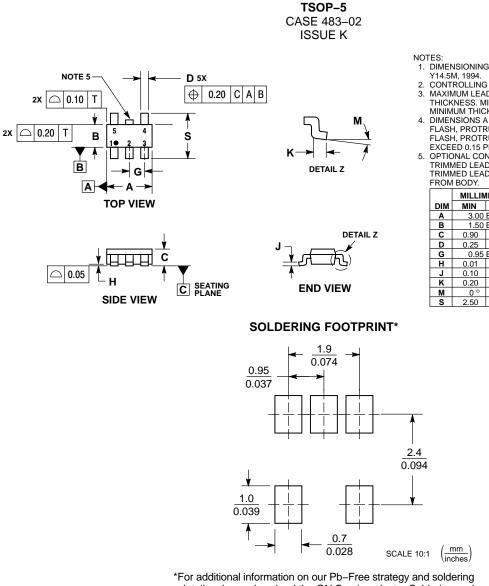
	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.50	0.55	0.60	0.020	0.022	0.024	
b	0.17	0.22	0.27	0.007	0.009	0.011	
С	0.08	0.13	0.18	0.003	0.005	0.007	
D	1.55	1.60	1.65	0.061	0.063	0.065	
Е	1.15	1.20	1.25	0.045	0.047	0.049	
е		0.50 BSC			0.020 BSC	)	
L	0.10	0.20	0.30	0.004	0.008	0.012	
HE	1.55	1.60	1.65	0.061	0.063	0.065	

RECOMMENDED SOLDERING FOOTPRINT\*



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### PACKAGE DIMENSIONS



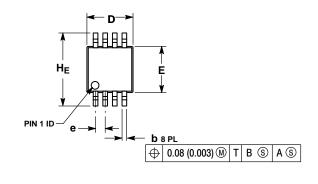
details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

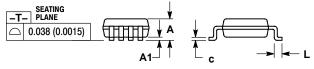
- CONTROLLING DIMENSION: MILLIMETERS.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.
  DIMENSIONS A AND B DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS. MOLD FLASH, PROTRUSIONS, OR GATE BURRS SHALL NOT EXCEED 0.15 PER SIDE. DIMENSION A.
  OPTIONAL CONSTRUCTION: AN ADDITIONAL TRIMMED LEAD IS ALLOWED IN THIS LOCATION. TRIMMED LEAD NOT TO EXTEND MORE THAN 0.2 FROM BODY.

THOM BOBIN							
	MILLIN	MILLIMETERS					
DIM	MIN	MAX					
Α	3.00	BSC					
В	1.50	BSC					
С	0.90	1.10					
D	0.25	0.50					
G	0.95	BSC					
Н	0.01	0.10					
J	0.10	0.26					
ĸ	0.20	0.60					
М	0 °	10 °					
S	2.50	3.00					

### PACKAGE DIMENSIONS

Micro8<sup>™</sup> CASE 846A-02 **ISSUE J** 



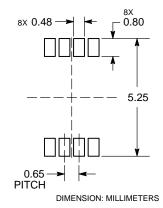


NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 1. 2.

- 2. CONTROLLING DIMENSION: MILLIMETER. 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS ON GATE BURRS. MOLD FLASH, PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
   DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
   846A-01 OBSOLETE, NEW STANDARD 846A-02.

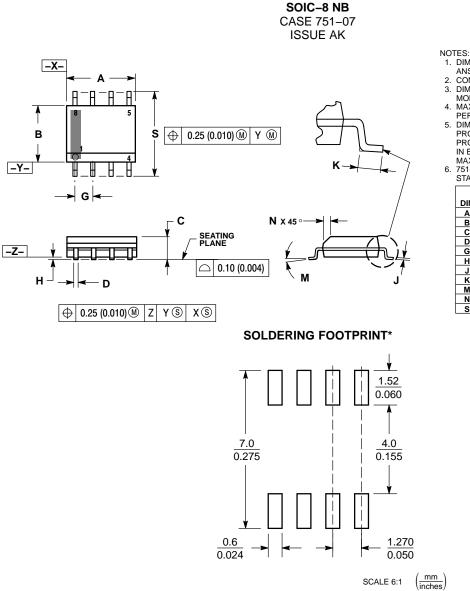
	MILLIMETERS			INCHES		
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α			1.10		1	0.043
A1	0.05	0.08	0.15	0.002	0.003	0.006
b	0.25	0.33	0.40	0.010	0.013	0.016
С	0.13	0.18	0.23	0.005	0.007	0.009
D	2.90	3.00	3.10	0.114	0.118	0.122
Е	2.90	3.00	3.10	0.114	0.118	0.122
е		0.65 BSC		0.026 BSC		
L	0.40	0.55	0.70	0.016	0.021	0.028
HE	4.75	4.90	5.05	0.187	0.193	0.199

RECOMMENDED SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

### PACKAGE DIMENSIONS



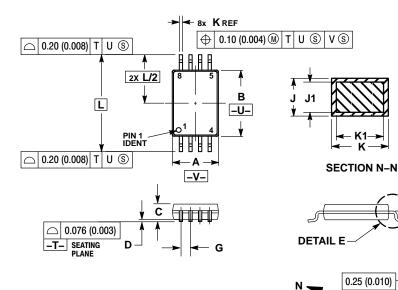
\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

- NOTES:
  DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
  CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION A AND B DO NOT INCLUDE MOLEON DEOTRICON
- MOLD PROTRUSION. MAXIMUM MOLD PROTRUSION 0.15 (0.006) 4. PER SIDE.
- PER SIDE. 5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 6. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

01/11									
	MILLIN	IETERS	INC	HES					
DIM	MIN	MAX	MIN	MAX					
Α	4.80	5.00	0.189	0.197					
В	3.80	4.00	0.150	0.157					
С	1.35	1.75	0.053	0.069					
D	0.33	0.51	0.013	0.020					
G	1.27	7 BSC	0.05	0 BSC					
Н	0.10	0.25	0.004	0.010					
J	0.19	0.25	0.007	0.010					
ĸ	0.40	1.27	0.016	0.050					
М	0 °	8 °	0 °	8 °					
N	0.25	0.50	0.010	0.020					
S	5.80	6.20	0.228	0.244					

### PACKAGE DIMENSIONS





-W-

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F DETAIL E

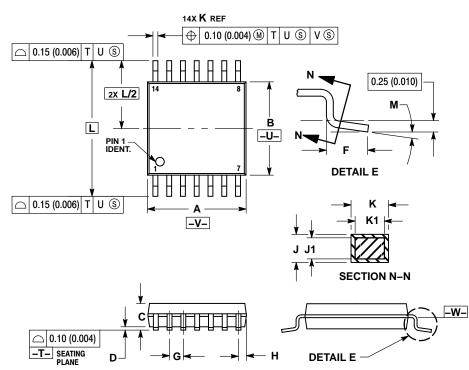
Ν

- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: MILLIMETER. 3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH. OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
- UNENSION B DOES NOT INCLUDE INTERLEAD
  FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010)
- PER SIDE. 5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY. 6. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	2.90	3.10	0.114	0.122
В	4.30	4.50	0.169	0.177
С		1.10		0.043
D	0.05	0.15	0.002	0.006
F	0.50	0.70	0.020	0.028
G	0.65	BSC	0.026 BSC	
J	0.09	0.20	0.004	0.008
J1	0.09	0.16	0.004	0.006
ĸ	0.19	0.30	0.007	0.012
K1	0.19	0.25	0.007	0.010
L	6.40		0.252	
М	0°	8°	0°	8 °

### PACKAGE DIMENSIONS

TSSOP-14 CASE 948G ISSUE B

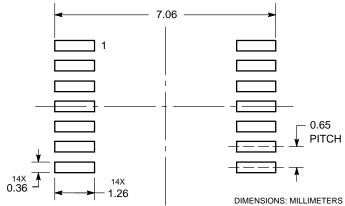


NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
   CONTROLLING DIMENSION: MILLIMETER.
- CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION A DOES NOT INCLUDE MOLD FLASH, PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT DUCTOR OF A DOALD TO THE DUCK OF T
- KOLD I LEAST OK OGO PER SIDE.
  L
  DIMENSION B DOES NOT INCLUDE
  INTERLEAD FLASH OR PROTRUSION.
  INTERLEAD FLASH OR PROTRUSION.
  INTERLEAD FLASH OR PROTRUSION.
  INTERLEAD FLASH OR PROTRUSION.
  INTERLEAD FLASH OR PROTRUSION.
- NOT EXCEED 0.25 (0.010) PER SIDE. 5. DIMENSION K DOES NOT INCLUDE DAMBAR PROTRUSION ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE K DIMENSION AT MAXIMUM MATERIAL CONDITION.
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
- DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE –W–.

	MILLIN	IETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.90	5.10	0.193	0.200	
В	4.30	4.50	0.169	0.177	
С		1.20		0.047	
D	0.05	0.15	0.002	0.006	
F	0.50	0.75	0.020	0.030	
G	0.65	BSC	0.026 BSC		
Н	0.50	0.60	0.020	0.024	
J	0.09	0.20	0.004	0.008	
J1	0.09	0.16	0.004	0.006	
κ	0.19	0.30	0.007	0.012	
K1	0.19	0.25	0.007	0.010	
L	6.40		0.252	2 BSC	
Μ	0 °	8 °	0 °	8 °	

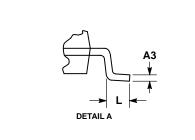
**SOLDERING FOOTPRINT\*** 



\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



SOIC-14 NB CASE 751A-03 ISSUE L



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м

5. MAXIMUM MOLD PROTRUSION 0.15 PER SIDE MILLIMETERS INCHES DIM MIN MAX MIN MAX 1.35 1.75 0.054 0.068 Α A1 0.10 0.25 0.004 0.010 0.19 0.25 0.008 0.010 0.49 0.014 0.019 A3 b 0.35 D 8.55 8.75 0.337 0.344 4.00 0.150 0.157 Е 3.80 1 27 BSC 0.050 BSC е 5.806.200.2280.2440.250.500.0100.019 н h 0.40 1.25 0.016 0.049 Ω Ω

MOLD PROTRUSIONS

 DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.

4. DIMENSIONS D AND E DO NOT INCLUDE

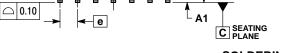
CONTROLLING DIMENSION: MILLIMETERS.

3. DIMENSION 6 DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF AT MAXIMUM MATERIAL CONDITION.

NOTES:

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DETAIL A



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⊕ 0.25 M

С

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В

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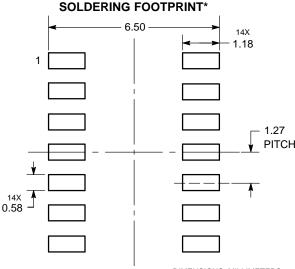
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DIMENSIONS: MILLIMETERS

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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